



Universität Siegen ARIES update Small Samples Update

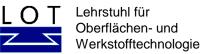
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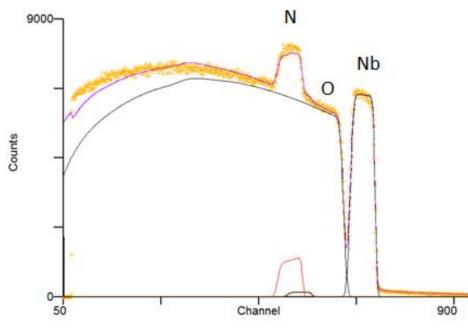
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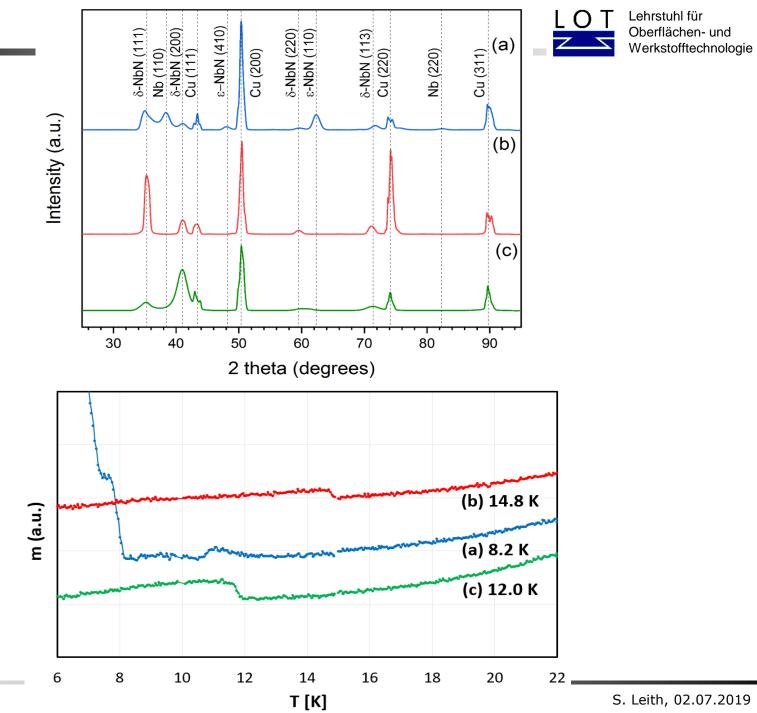


- **RBS Analysis:** \leq 20 % N flow rate are found to be under stoichiometric and within the range for δ -NbN
- The high percentage of N within the films indicates a lack of the β -NbN and γ -NbN phases, x = 0.4 to 0.8
- The decrease in oxygen content in the films with increasing nitrogen flow will affect the absolute stoichiometry of the NbN films



N ₂ flow	Nb	Ν	0	х
%	(at.%)	(at.%)	(at.%)	^
10	48.8	46.2	5	0.95
15	48.75	45.17	6.07	0.93
20	48.30	45.75	6	0.95
25	45.71	51.37	2.90	1.12
30	48.70	50.86	0.43	1.04







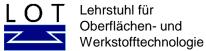


For your later reference

- *T_c* **Results:** All the investigated samples were found to be superconducting, with T_c ranging from 8.2 K to 14.8 K.
- Larger Ar/N_2 ratio films proved to be superior.
- Sample (a) presents two distinct transition points at 8.2 K and 10.8 K, which indicates the presence of two separate superconducting phases, as confirmed by the XRD analysis.
- Sample (b) shows the highest T_c which is in compliance with XRD and SEM results.
- Crystal size and/or orientation seems to lead to a decrease in the T_{c_1} as revealed by sample (c).
- **XRD Results:** Indicative samples shown
- Sample (a): phase mixture of δ and ε -NbN. Nb interlayer detected.
- Sample (b) and (c): cubic δ -NbN films.
- (b) shows relatively sharp NbN peaks which are oriented along the [111] growth direction
- (c) has broadened peaks and exhibits a different growth orientation in [200] direction.
- Sample (b) features a columnar growth. Diameter of more than 100nm, explaining the found orientation and sharp peaks
- (c) the columns are a few nm in diameter which, in turn, leads to broadened XRD peaks.



Film deposition



- NbN film deposited onto EP polished copper sample
 - $S_q = 63 \text{ nm} \pm 7 \text{ nm} \text{ vs} 844 \text{ nm}$ original (CFM scan size 257 x 257 μ m)



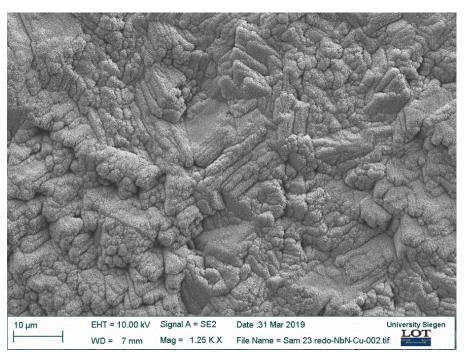
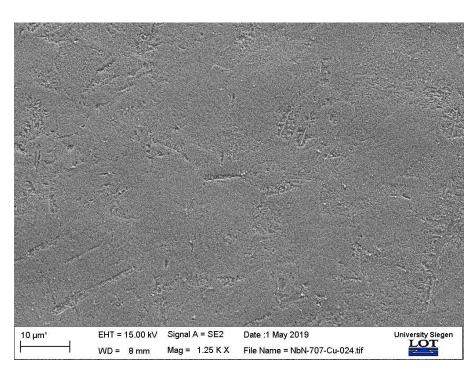


Figure: (Left) Nitric Acid NbN/Cu. (Right) EP NbN/Cu







Future Work

- Investigate the use of interlayers and deposit optimised NbN films onto different surface treated copper surfaces
- Deposit HiPIMS Nb and NbN films
- Deposit multilayer samples onto copper (e.g. Nb AlN NbN or Nb NbN)
- Investigate N-doped Nb thin films on copper